

Notice of References Cited	Application/Control No. 10/541,144	Applicant(s)/Patent Under Reexamination GOHARY ET AL.	
	Examiner Liam J. Heincer	Art Unit 1709	Page 1 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2,455,652 A	12-1948	BRALLEY JAMES A; et. al.	526/227
*	B	US-3,284,512 A	11-1966	HENNIS HENRY E; et. al.	568/722
*	C	US-3,466,259 A	09-1969	JERNIGAN JACK W	523/211
*	D	US-3,749,600 A	07-1973		106/18.18
*	E	US-3,915,926 A	10-1975	Wambach, Allen D.	524/411
*	F	US-3,947,524 A	03-1976	Hozumi et al.	525/67
*	G	US-3,981,843 A	09-1976	Yoshizaki et al.	524/409
*	H	US-4,290,846 A	09-1981	Muntwyler, Rene	162/161
*	I	US-4,348,309 A	09-1982	Pruess, Warren W.	523/336
*	J	US-4,361,623 A	11-1982	Newkirk et al.	428/394
*	K	US-4,524,164 A	06-1985	Viswanathan et al.	524/14
*	L	US-4,567,218 A	01-1986	Petiet, Thomas J.	524/373
*	M	US-4,629,750 A	12-1986	Hepp, Leonard R.	523/201

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/541,144		Applicant(s)/Patent Under Reexamination GOHARY ET AL.	
	Examiner Liam J. Heincer		Art Unit 1709	Page 2 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,648,988 A	03-1987	Van Dijk et al.	252/602
*	B	US-4,699,942 A	10-1987	Weaver et al.	524/338
*	C	US-4,943,612 A	07-1990	Morita et al.	524/714
*	D	US-5,043,368 A	08-1991	Minnick, Michael G.	523/444
*	E	US-5,055,247 A	10-1991	Ueda et al.	264/109
*	F	US-5,177,128 A	01-1993	Lindemann et al.	524/44
*	G	US-5,302,761 A	04-1994	Tamabayashi et al.	568/726
*	H	US-5,441,742 A	08-1995	Autant et al.	424/405
*	I	US-5,571,854 A	11-1996	Ishida et al.	524/342
*	J	US-5,916,356 A	06-1999	Williams et al.	106/18.32
*	K	US-6,051,662 A	04-2000	Tracy et al.	525/393
*	L	US-6,147,264 A	11-2000	Manimaran et al.	568/726
*	M	US-2001/0044488 A1	11-2001	Yasuda et al.	524/341

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/541,144	Applicant(s)/Patent Under Reexamination GOHARY ET AL.	
	Examiner Liam J. Heincer	Art Unit 1709	Page 3 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,313,355 B1	11-2001	Manimaran et al.	568/726
*	B	US-2002/0120041 A1	08-2002	Zingg et al.	524/100
*	C	US-2002/0193487 A1	12-2002	Sakurai et al.	524/417
*	D	US-2003/0078324 A1	04-2003	Terada et al.	524/115
*	E	US-6,610,765 B1	08-2003	Pfaendner et al.	524/108
*	F	US-6,627,676 B1	09-2003	George et al.	523/122
*	G	US-2003/0191213 A1	10-2003	Troutman et al.	524/99
*	H	US-2003/0187102 A1	10-2003	Medoff et al.	524/9
*	I	US-2004/0016909 A1	01-2004	Zhang et al.	252/380
*	J	US-2004/0138351 A1	07-2004	Kaprinidis et al.	524/100
*	K	US-6,787,590 B2	09-2004	Nakayama et al.	524/9
*	L	US-2005/0065275 A1	03-2005	Takahashi et al.	524/588
*	M	US-2006/0089440 A1	04-2006	Ha et al.	524/405

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/541,144	Applicant(s)/Patent Under Reexamination GOHARY ET AL.	
	Examiner Liam J. Heincer	Art Unit 1709	Page 4 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0167164 A1	07-2006	Sugioka et al.	524/492
*	B	US-7,074,459 B2	07-2006	Stockel, Richard F.	427/440
*	C	US-2006/0145383 A9	07-2006	Manning et al.	264/122
*	D	US-2006/0264545 A1	11-2006	Wakabayashi et al.	524/394
*	E	US-6,383,127 B2	05-2002	Fushihara et al.	567/725
*	F	US-2004/0076847 A1	04-2004	Saunders, JR. et al	428/535
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.